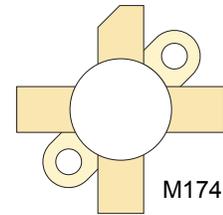


RF POWER VERTICAL MOSFET

The VRF150 is a gold-metallized silicon n-channel RF power transistor designed for broadband commercial and military applications requiring high power and gain without compromising reliability, ruggedness, or inter-modulation distortion.



FEATURES

- Improved Ruggedness $V_{(BR)DSS} = 170V$
- 150W with 11dB Typical Gain @ 150MHz, 50V
- 150W with 18dB Typical Gain @ 30MHz, 50V
- Excellent Stability & Low IMD
- Common Source Configuration
- Available in Matched Pairs
- 70:1 Load VSWR Capability at Specified Operating Conditions
- Nitride Passivated
- Refractory Gold Metallization
- High Voltage Replacement for MRF150
- RoHS Compliant 

Maximum Ratings

All Ratings: $T_c = 25^\circ C$ unless otherwise specified

| Symbol | Parameter | VRF150(MP) | Unit |
|-----------|---|------------|------|
| V_{DSS} | Drain-Source Voltage | 170 | V |
| I_D | Continuous Drain Current @ $T_c = 25^\circ C$ | 16 | A |
| V_{GS} | Gate-Source Voltage | ± 40 | V |
| P_D | Total Device dissipation @ $T_c = 25^\circ C$ | 300 | W |
| T_{STG} | Storage Temperature Range | -65 to 150 | °C |
| T_J | Operating Junction Temperature | 200 | |

Static Electrical Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit |
|---------------|--|-----|-----|-----|---------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage ($V_{GS} = 0V, I_D = 100mA$) | 170 | 180 | | V |
| $V_{DS(ON)}$ | On State Drain Voltage ($I_{D(ON)} = 10A, V_{GS} = 10V$) | | 2.0 | 3.0 | |
| I_{DSS} | Zero Gate Voltage Drain Current ($V_{DS} = 100V, V_{GS} = 0V$) | | | 1.0 | mA |
| I_{GSS} | Gate-Source Leakage Current ($V_{GS} = \pm 20V, V_{DS} = 0V$) | | | 1.0 | μA |
| g_{fs} | Forward Transconductance ($V_{DS} = 10V, I_D = 5A$) | 4.5 | | | mhos |
| $V_{GS(TH)}$ | Gate Threshold Voltage ($V_{DS} = 10V, I_D = 100mA$) | 2.9 | 3.6 | 4.4 | V |

Thermal Characteristics

| Symbol | Characteristic | Min | Typ | Max | Unit |
|-----------------|-------------------------------------|-----|-----|------|------|
| $R_{\theta JC}$ | Junction to Case Thermal Resistance | | | 0.60 | °C/W |

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Dynamic Characteristics

VRF150(MP)

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Unit |
|-----------|------------------------------|---|-----|-----|-----|------|
| C_{iss} | Input Capacitance | $V_{GS} = 0V$ $V_{DS} = 50V$ $f = 1MHz$ | | 420 | | pF |
| C_{oss} | Output Capacitance | | | 210 | | |
| C_{rss} | Reverse Transfer Capacitance | | | 35 | | |

Functional Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit |
|---------------------|---|--------------------------------|-----|-----|------|
| G_{PS} | $f_1 = 30MHz, f_2 = 30.001MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 150W_{PEP}^1$ | | 18 | | dB |
| G_{PS} | $f = 150MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 150W$ | | 11 | | |
| η_D | $f_1 = 30MHz, f_2 = 30.001MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 150W_{PEP}^1$ | | 50 | | % |
| IMD _(d3) | $f_1 = 30MHz, f_2 = 30.001MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 150W_{PEP}^1$ | | -32 | | dBc |
| ψ | $f_1 = 30MHz, V_{DD} = 50V, I_{DQ} = 250mA, P_{out} = 150W$ CW 70:1 VSWR - All Phase Angles, 0.2mSec X 20% Duty Factor | No Degradation in Output Power | | | |

Class A Characteristics

| Symbol | Test Conditions | Min | Typ | Max | Unit |
|-------------------------|---|-----|-----|-----|------|
| G_{PS} | $V_{DD} = 50V, I_{DQ} = 3A, P_{out} = 150W_{PEP}, f_1 = 30MHz, f_2 = 30.001MHz$ | | 20 | | dB |
| IMD _(d3) | | | -50 | | |
| IMD _(d9-d13) | | | -75 | | |

1. To MIL-STD-1311 Version A, test method 2204B, Two Tone, Reference Each Tone

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

Typical Performance Curves

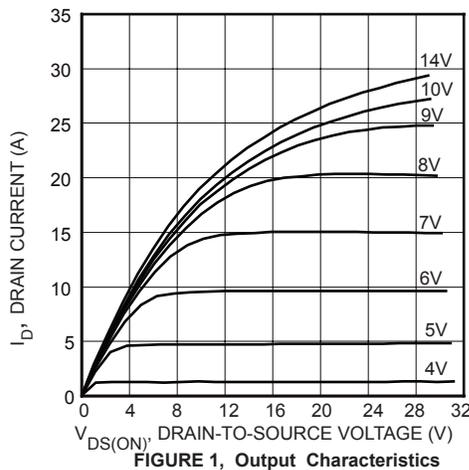


FIGURE 1, Output Characteristics

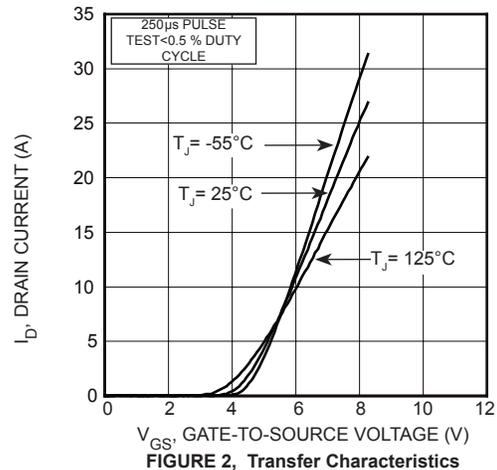


FIGURE 2, Transfer Characteristics

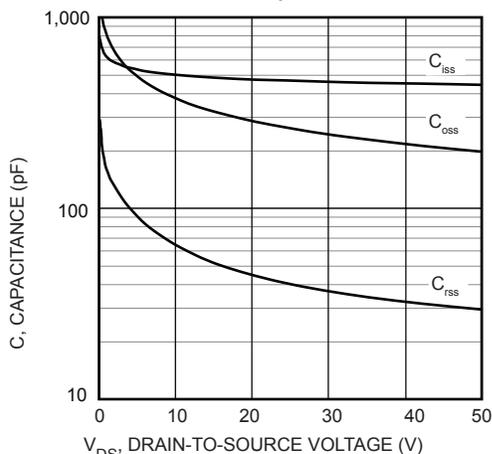


FIGURE 3, Capacitance vs Drain-to-Source Voltage

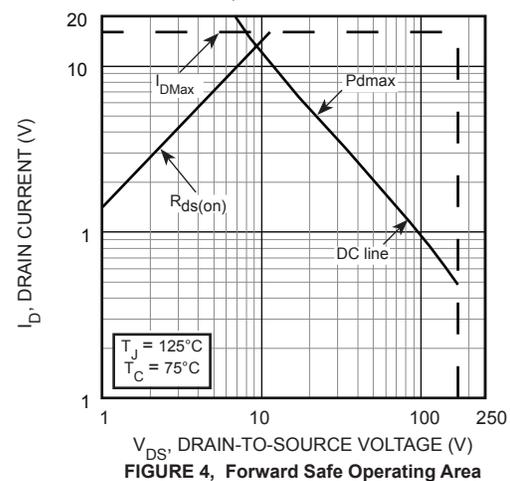


FIGURE 4, Forward Safe Operating Area

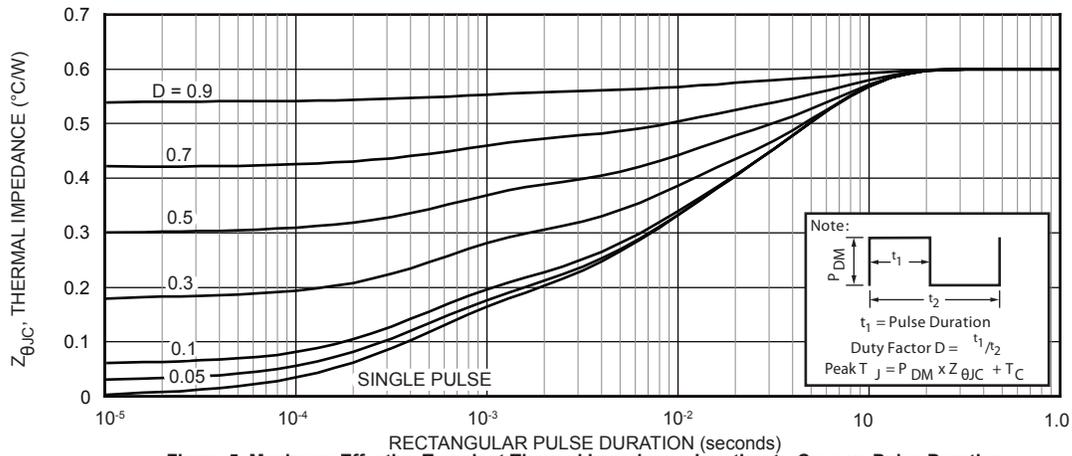


Figure 5. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

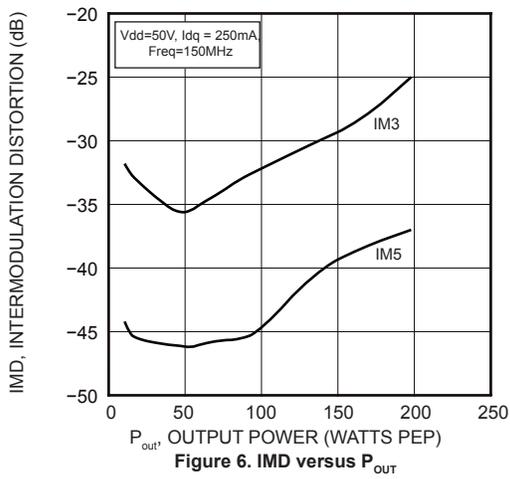


Figure 6. IMD versus P_{OUT}

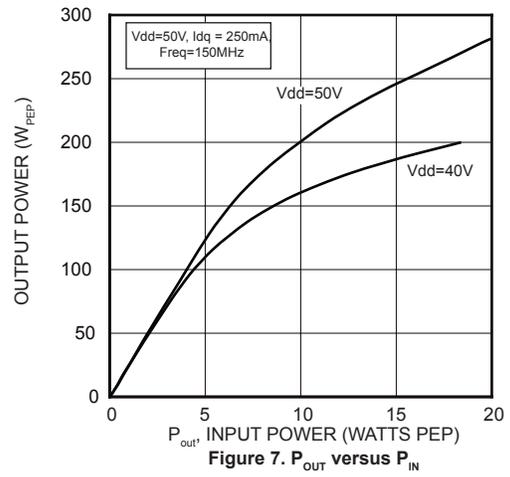
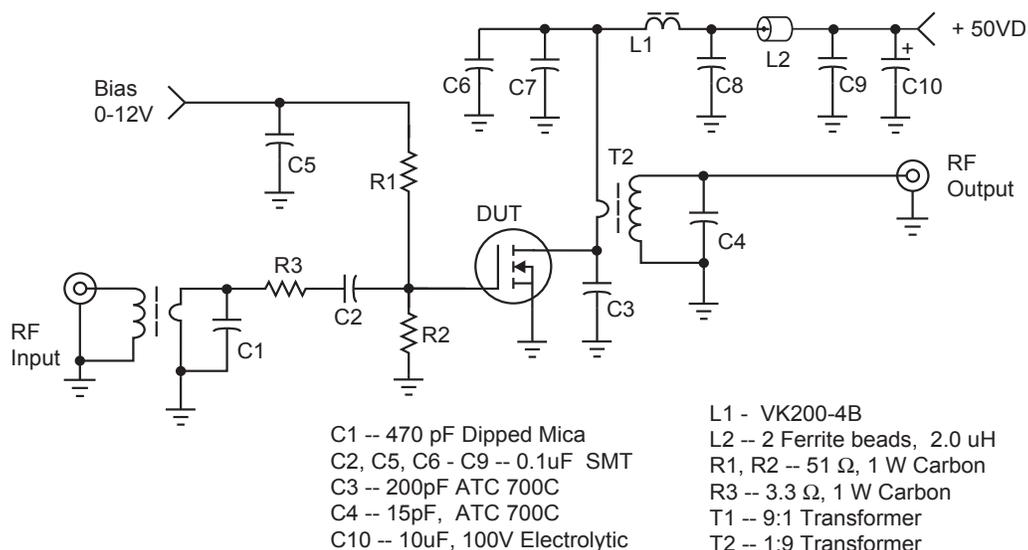
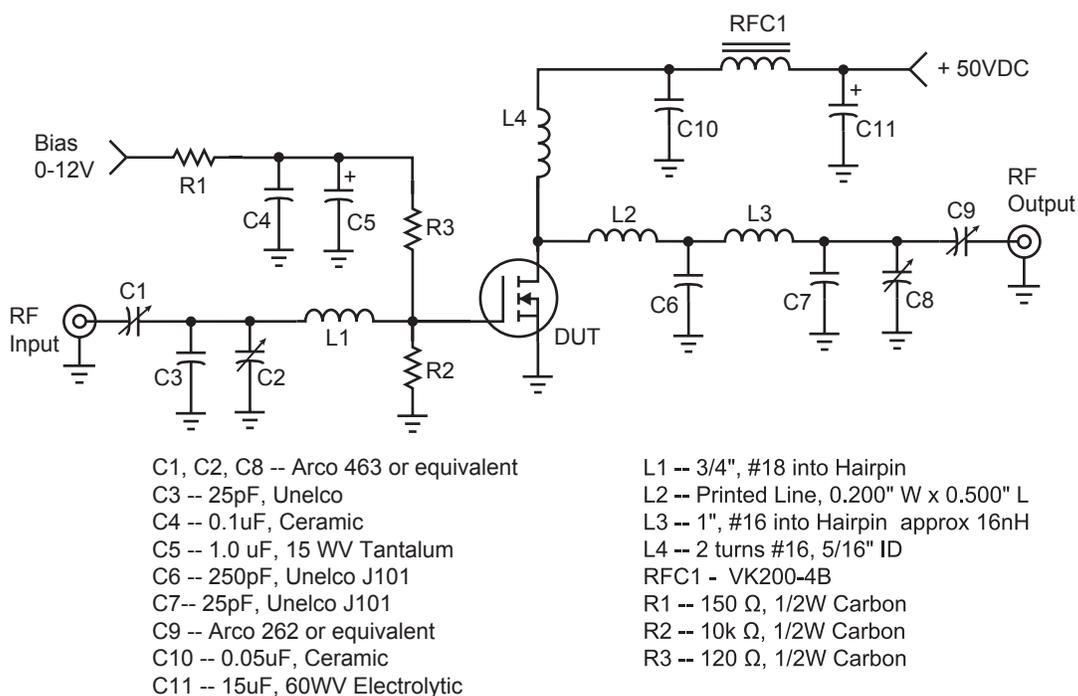


Figure 7. P_{OUT} versus P_{IN}

30 MHz test Circuit



150 MHz test Circuit

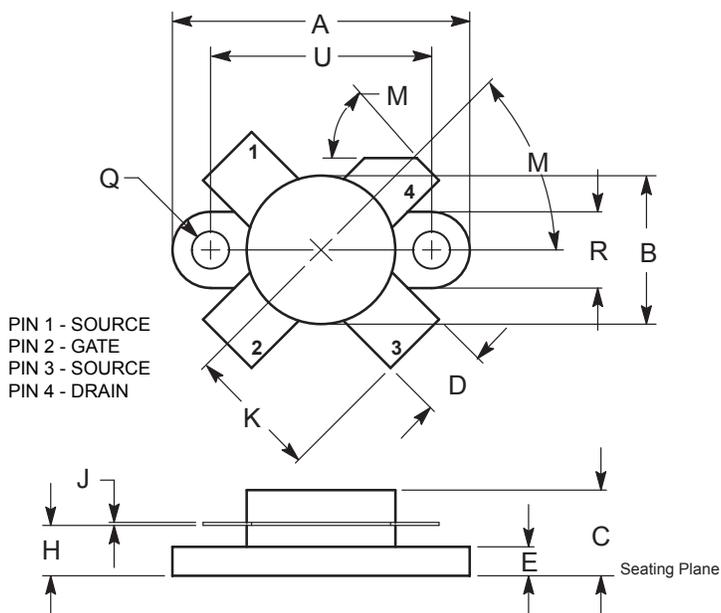


Adding MP at the end of P/N specifies a matched pair where $V_{GS(TH)}$ is matched between the two parts. V_{TH} values are marked on the devices per the following table.

| Code | Vth Range | Code 2 | Vth Range |
|------|---------------|--------|---------------|
| A | 2.900 - 2.975 | M | 3.650 - 3.725 |
| B | 2.975 - 3.050 | N | 3.725 - 3.800 |
| C | 3.050 - 3.125 | P | 3.800 - 3.875 |
| D | 3.125 - 3.200 | R | 3.875 - 3.950 |
| E | 3.200 - 3.275 | S | 3.950 - 4.025 |
| F | 3.275 - 3.350 | T | 4.025 - 4.100 |
| G | 3.350 - 3.425 | W | 4.100 - 4.175 |
| H | 3.425 - 3.500 | X | 4.175 - 4.250 |
| J | 3.500 - 3.575 | Y | 4.250 - 4.325 |
| K | 3.575 - 3.650 | Z | 4.325 - 4.400 |

V_{TH} values are based on Microsemi measurements at datasheet conditions with an accuracy of 1.0%.

.5" SOE Package Outline
All Dimensions are ± .005



| DIM | INCHES | | MILLIMETERS | |
|-----|---------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.096 | 0.990 | 24.39 | 25.14 |
| B | 0.465 | 0.510 | 11.82 | 12.95 |
| C | 0.229 | 0.275 | 5.82 | 6.98 |
| D | 0.216 | 0.235 | 5.49 | 5.96 |
| E | 0.084 | 0.110 | 2.14 | 2.79 |
| H | 0.144 | 0.178 | 3.66 | 4.52 |
| J | 0.003 | 0.007 | 0.08 | 0.17 |
| K | 0.435 | | 11.0 | |
| M | 45° NOM | | 45° NOM | |
| Q | 0.115 | 0.130 | 2.93 | 3.30 |
| R | 0.246 | 0.255 | 6.25 | 6.47 |
| U | 0.720 | 0.730 | 18.29 | 18.54 |

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